BFP842ESD

Robust Low Noise Silicon Germanium Bipolar RF Transistor

Data Sheet

Revision 1.1, 2013-04-11

RF & Protection Devices

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BFP842ESD, Robust Low Noise Silicon Germanium Bipolar RF Transistor

Revision History: 2013-04-11, Revision 1.1

Page	Subjects (major changes since last revision)
	This data sheet replaces the revision from 2012-08-03.
P. 8	Item about AEC-Q101 added to feature list, minor changes.
P. 27	Picture for marking description updated.

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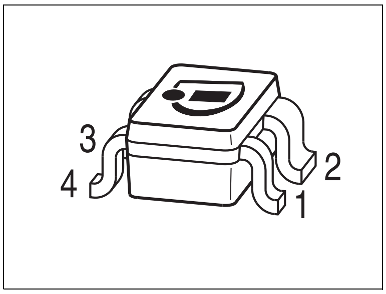
1 Product Brief

The BFP842ESD is a high performance HBT (Heterojunction Bipolar Transistor) specifically designed for 2.3 - 3.5 GHz LNA applications. The device is based upon the reliable high volume SiGe:C technology of Infineon.
The BFP842ESD provides inherently good input power match as well as inherently good noise match between 2.3 and 3.5 GHz. The simultaneous noise and power match without lossy external matching components at the input leads to a low external parts count, to a very good noise figure and to a high transducer gain in the application. Integrated protection elements at in- and output make the device robust against ESD and excessive RF input power.
The device offers its high performance at low current and voltage and is especially well-suited for portable battery-powered applications in which energy efficiency is a key requirement. The device comes in an easy to use industry standard package with visible leads.

2 Features

- Robust very low noise amplifier based on Infineon´s reliable, high volume SiGe:C technology
- Unique combination of high-end RF performance and robustness: 16 dBm maximum RF input power, 1 kV HBM ESD hardness
- High linearity $OIP3$ = 25.5 dBm at 3.5 GHz, 2.5 V, 15 mA
- High transition frequency f_T = 60 GHz enables very low noise figure at high frequencies: NF_{min} = 0.65 dB at 3.5 GHz, 2.5 V, 5 mA
- Transducer gain $|S_{21}|^2$ = 16 dB @ 3.5 GHz, 2.5 V, 15 mA
- Ideal for low voltage applications e.g. V_{CC} = 1.8 V and 2.85 V (3.3 V, 3.6 V requires corresponding collector resistor)
- Low power consumption, ideal for mobile applications
- Easy to use Pb free (RoHS compliant) and halogen free industry standard package with visible leads
- Qualification report according to AEC-Q101 available



SOT343

Applications

As very low noise amplifier (LNA) in

- Mobile and fixed connectivity applications: WLAN 802.11b/g/n, WiMAX 2.5/3.5 GHz, Bluetooth
- Satellite communication systems: GNSS Navigation systems (GPS, GLONASS, COMPASS/Beidu/Galileo) Satellite radio (SDARs, DAB and C-band LNB) and C-band LNB (1st and 2nd stage LNA)
- Multimedia applications such as mobile/portable TV, Mobile TV, FM Radio
- 3G/4G UMTS/LTE mobile phone applications
- ISM applications like RKE, AMR and Zigbee

As discrete active mixer, buffer amplifier in VCOs

Attention: ESD (Electrostatic discharge) sensitive device, observe handling precautions

Product Name	Package	Pin Configuration				Marking
BFP842ESD	SOT343	1 = B	2 = E	3 = C	4 = E	T9s

3 Maximum Ratings

Table 3-1 Maximum Ratings at T_A = 25 °C (unless otherwise specified)

Parameter	Symbol	Values		Unit	Note / Test Condition
		Min.	Max.		
Collector emitter voltage	V_{CEO}	–	3.25 2.9	V	T_A = 25 °C T_A = -40 °C Open base
Collector emitter voltage[1)]	V_{CES}	–	3.25 2.9	V	T_A = 25 °C T_A = -40 °C E-B short circuited
Collector base voltage[2)]	V_{CBO}	–	4.1 3.5	V	T_A = 25 °C T_A = -40 °C Open emitter
Base current	I_B	-5	3	mA	
Collector current	I_C	–	40	mA	
RF input power	P_{RFin}	–	16	dBm	
ESD stress pulse	V_{ESD}	-1	1	kV	HBM, all pins, acc. to JESD22-A114
Total power dissipation[3)]	P_{tot}	–	120	mW	$T_S \leq 111$°C
Junction temperature	T_J	–	150		
Storage temperature	T_{Stg}	-55	150	°C	

1) V_{CES} is identical to V_{CEO} due to design
2) V_{CBO} is similar to V_{CEO} due to design
3) T_S is the soldering point temperature. T_S is measured on the emitter lead at the soldering point of the pcb.

***Attention:** Stresses above the max. values listed here may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Maximum ratings are absolute ratings; exceeding only one of these values may cause irreversible damage to the integrated circuit.*

4 Thermal Characteristics

Table 4-1 Thermal Resistance

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Junction - soldering point[1]	R_{thJS}		324		K/W	

1) For the definition of R_{thJS} please refer to Application Note AN077 (Thermal Resistance Calculation)

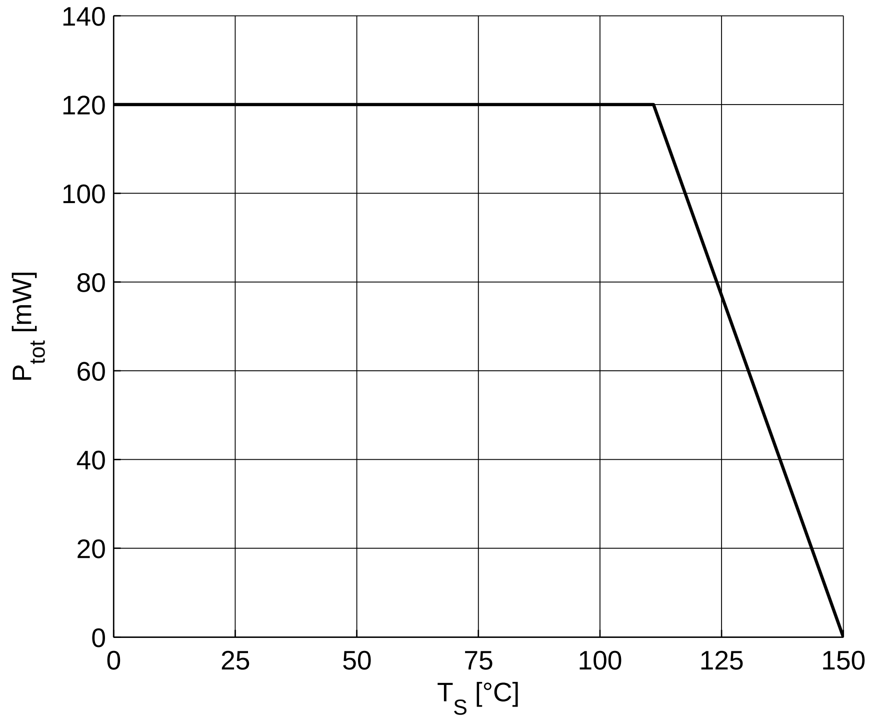


Figure 4-1 Total Power Dissipation P_{tot} = f (T_S)

5 Electrical Characteristics

5.1 DC Characteristics

Table 5-1 DC Characteristics at T_A = 25 °C

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Collector emitter breakdown voltage	$V_{(BR)CEO}$	3.25	3.7		V	I_C = 1 mA, I_B = 0 Open base
Collector emitter leakage current	I_{CES}			400	nA	V_{CE} = 2 V, V_{BE} = 0 E-B short circuited
Collector base leakage current	I_{CBO}			400	nA	V_{CB} = 2 V, I_E = 0 Open emitter
Emitter base leakage current	I_{EBO}			10	µA	V_{EB} = 0.5 V, I_C = 0 Open collector
DC current gain	h_{FE}	150	260	450		V_{CE} = 2.5 V, I_C = 15 mA Pulse measured

5.2 General AC Characteristics

Table 5-2 General AC Characteristics at T_A = 25 °C

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Transition frequency	f_T		57		GHz	V_{CE} = 2.5 V, I_C = 25 mA f = 1 GHz
Collector base capacitance	C_{CB}		64		fF	V_{CB} = 2 V, V_{BE} = 0 f = 1 MHz Emitter grounded
Collector emitter capacitance	C_{CE}		0.46		pF	V_{CE} = 2 V, V_{BE}= 0 f = 1 MHz Base grounded
Emitter base capacitance	C_{EB}		0.44		pF	V_{EB} = 0.4 V,V_{CB} = 0 f = 1 MHz Collector grounded

5.3 Frequency Dependent AC Characteristics

Measurement setup is a test fixture with Bias T´s in a 50 Ω system, T_A = 25 °C

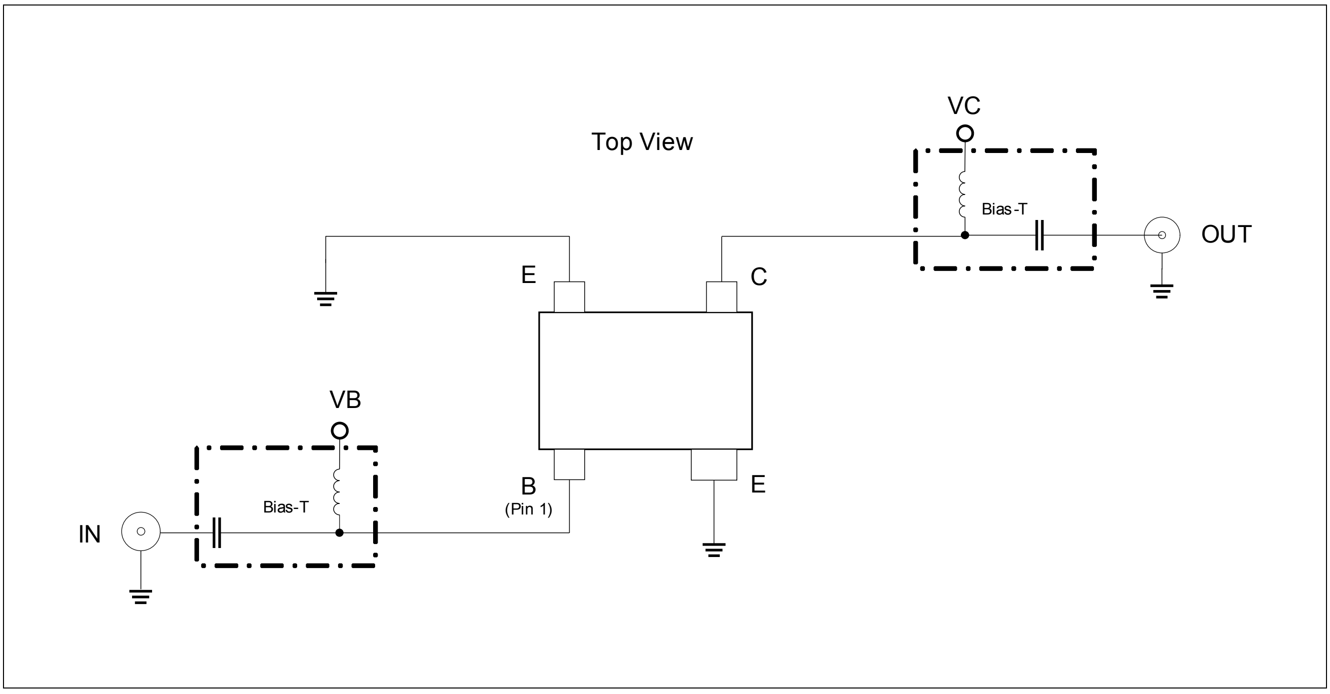


Figure 5-1 BFP842ESD Testing Circuit

Table 5-3 AC Characteristics, V_{CE} = 2.5 V, f = 0.45 GHz

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Power Gain					dB	
Maximum power gain	G_{ms}	–	33	–		I_C = 15 mA
Transducer gain	$\|S_{21}\|^2$	–	29.5	–		I_C = 15 mA
Minimum Noise Figure					dB	
Minimum noise figure	NF_{min}	–	0.4	–		I_C = 5 mA
Associated gain	G_{ass}	–	26	–		I_C = 5 mA
Linearity					dBm	$Z_S = Z_L$ = 50 Ω
1 dB compression point at output	OP_{1dB}	–	6.5	–		I_C = 15 mA
3rd order intercept point at output	$OIP3$	–	22	–		I_C = 15 mA

Table 5-4 AC Characteristics, V_{CE} = 2.5 V, f = 0.9 GHz

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Power Gain					dB	
Maximum power gain	G_{ms}	–	29	–		I_C = 15 mA
Transducer gain	$\lvert S_{21}\rvert^2$	–	26	–		I_C = 15 mA
Minimum Noise Figure					dB	
Minimum noise figure	NF_{min}	–	0.45	–		I_C = 5 mA
Associated gain	G_{ass}	–	24	–		I_C = 5 mA
Linearity					dBm	Z_S = Z_L = 50 Ω
1 dB compression point at output	OP_{1dB}	–	7	–		I_C = 15 mA
3rd order intercept point at output	$OIP3$	–	22.5	–		I_C = 15 mA

Table 5-5 AC Characteristics, V_{CE} = 2.5 V, f = 1.5 GHz

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Power Gain					dB	
Maximum power gain	G_{ms}	–	25.5	–		I_C = 15 mA
Transducer gain	$\lvert S_{21}\rvert^2$	–	23	–		I_C = 15 mA
Minimum Noise Figure					dB	
Minimum noise figure	NF_{min}	–	0.45	–		I_C = 5 mA
Associated gain	G_{ass}	–	21	–		I_C = 5 mA
Linearity					dBm	Z_S = Z_L = 50 Ω
1 dB compression point at output	OP_{1dB}	–	7.5	–		I_C = 15 mA
3rd order intercept point at output	$OIP3$	–	23.5	–		I_C = 15 mA

Table 5-6 AC Characteristics, V_{CE} = 2.5 V, f = 1.9 GHz

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Power Gain					dB	
Maximum power gain	G_{ms}	–	23.5	–		I_C = 15 mA
Transducer gain	$\lvert S_{21}\rvert^2$	–	21	–		I_C = 15 mA
Minimum Noise Figure					dB	
Minimum noise figure	NF_{min}	–	0.5	–		I_C = 5 mA
Associated gain	G_{ass}	–	19.5	–		I_C = 5 mA
Linearity					dBm	Z_S = Z_L = 50 Ω
1 dB compression point at output	OP_{1dB}	–	8	–		I_C = 15 mA
3rd order intercept point at output	$OIP3$	–	24.5	–		I_C = 15 mA

Table 5-7 AC Characteristics, V_{CE} = 2.5 V, f = 2.4 GHz

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Power Gain					dB	
Maximum power gain	G_{ms}	–	22	–		I_C = 15 mA
Transducer gain	$\|S_{21}\|^2$	–	19	–		I_C = 15 mA
Minimum Noise Figure					dB	
Minimum noise figure	NF_{min}	–	0.5	–		I_C = 5 mA
Associated gain	G_{ass}	–	18	–		I_C = 5 mA
Linearity					dBm	$Z_S = Z_L$ = 50 Ω
1 dB compression point at output	OP_{1dB}	–	8	–		I_C = 15 mA
3rd order intercept point at output	$OIP3$	–	25	–		I_C = 15 mA

Table 5-8 AC Characteristics, V_{CE} = 2.5 V, f = 3.5 GHz

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Power Gain					dB	
Maximum power gain	G_{ma}	–	17.5	–		I_C = 15 mA
Transducer gain	$\|S_{21}\|^2$	–	16	–		I_C = 15 mA
Minimum Noise Figure					dB	
Minimum noise figure	NF_{min}	–	0.65	–		I_C = 5 mA
Associated gain	G_{ass}	–	15	–		I_C = 5 mA
Linearity					dBm	$Z_S = Z_L$ = 50 Ω
1 dB compression point at output	OP_{1dB}	–	8.5	–		I_C = 15 mA
3rd order intercept point at output	$OIP3$	–	25.5	–		I_C = 15 mA

Table 5-9 AC Characteristics, V_{CE} = 2.5 V, f = 5.5 GHz

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Power Gain					dB	
Maximum power gain	G_{ma}	–	12.5	–		I_C = 15 mA
Transducer gain	$\|S_{21}\|^2$	–	11.5	–		I_C = 15 mA
Minimum Noise Figure					dB	
Minimum noise figure	NF_{min}	–	0.85	–		I_C = 5 mA
Associated gain	G_{ass}	–	10.5	–		I_C = 5 mA
Linearity					dBm	$Z_S = Z_L$ = 50 Ω
1 dB compression point at output	OP_{1dB}	–	8	–		I_C = 15 mA
3rd order intercept point at output	$OIP3$	–	24	–		I_C = 15 mA

Note: OIP3 value depends on termination of all intermodulation frequency components. Termination used for this measurement is 50 Ω from 0.2 MHz to 12 GHz.

5.4 Characteristic DC Diagrams

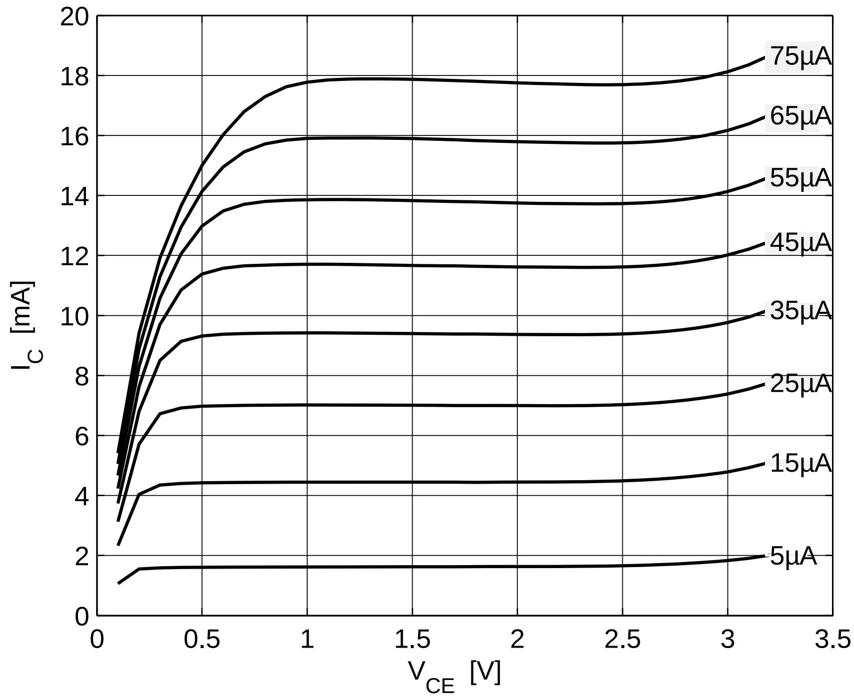


Figure 5-2 Collector Current vs. Collector Emitter Voltage $I_C = f(V_{CE})$, I_B = Parameter

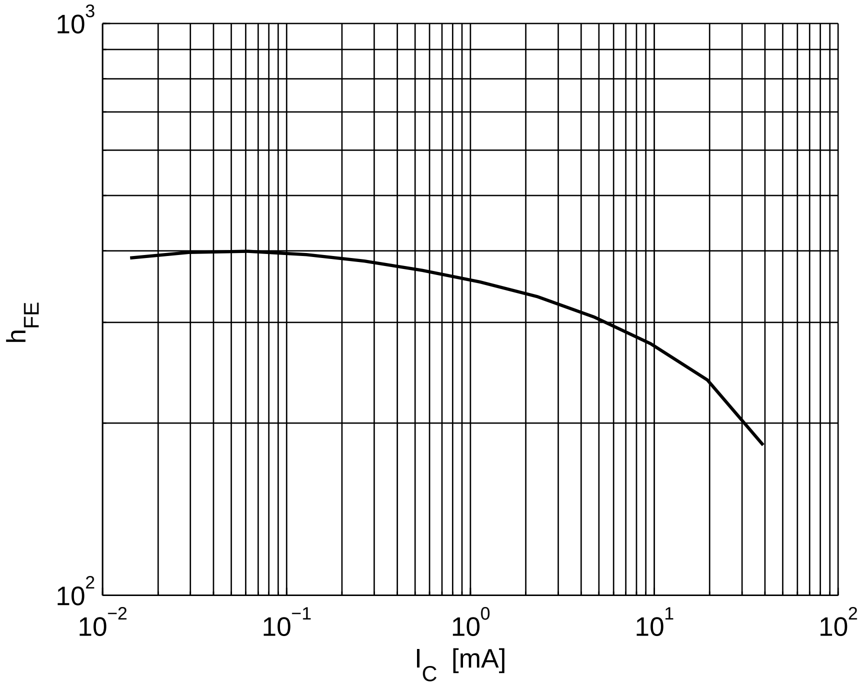


Figure 5-3 DC Current Gain $h_{FE} = f(I_C)$, V_{CE} = 2.5 V

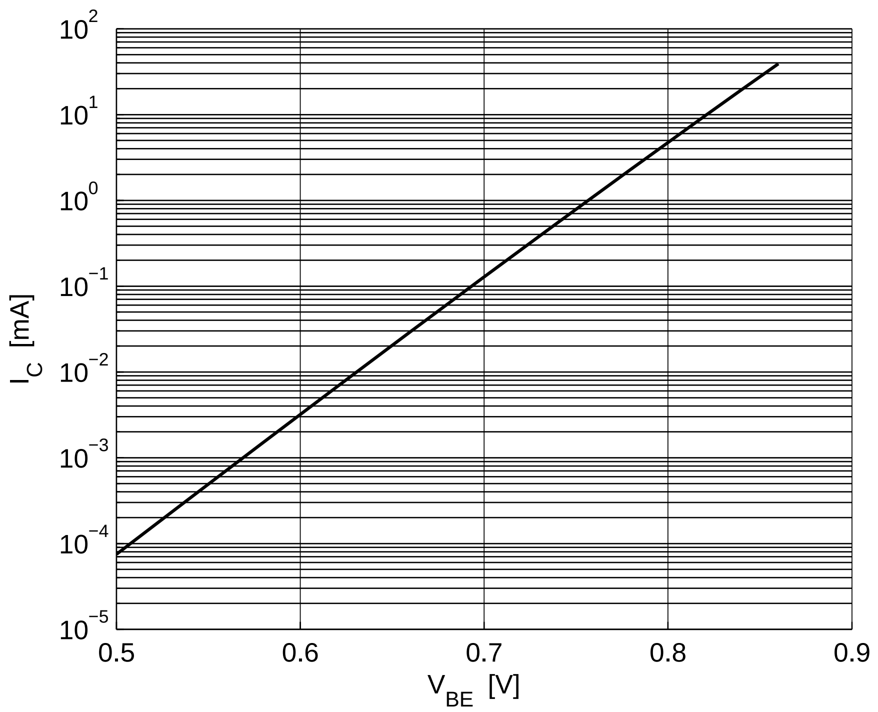


Figure 5-4 Collector Current vs. Base Emitter Forward Voltage $I_C = f(V_{BE})$, V_{CE} = 2.5 V

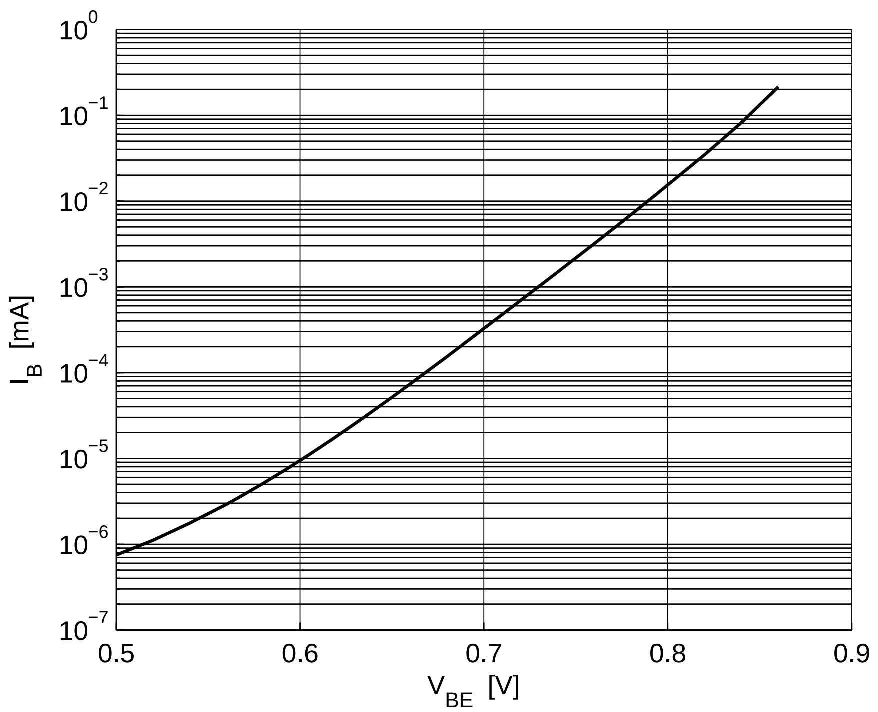


Figure 5-5 Base Current vs. Base Emitter Forward Voltage $I_B = f(V_{BE})$, V_{CE} = 2.5 V

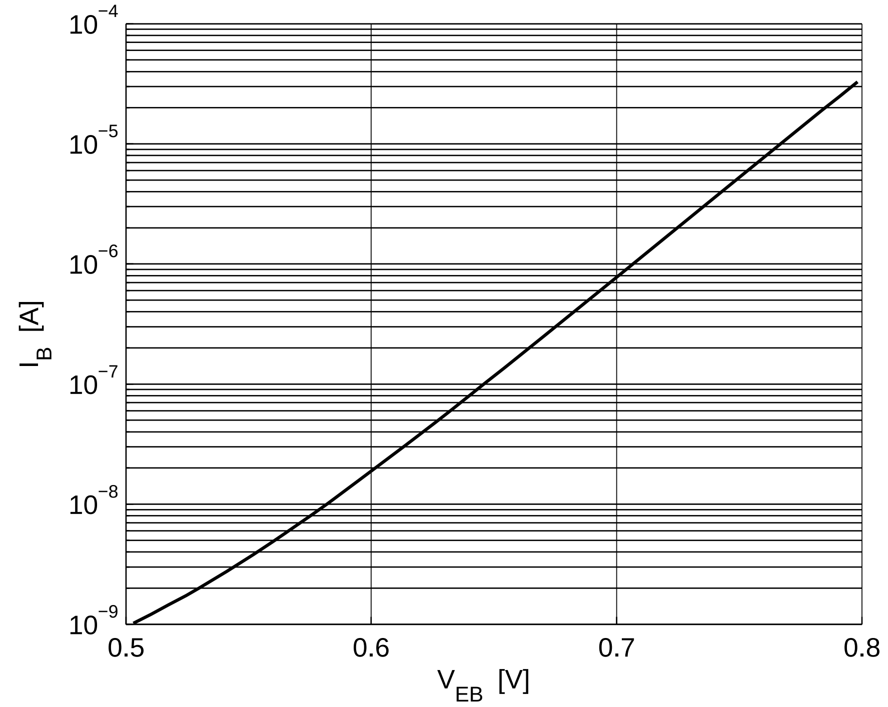


Figure 5-6 Base Current vs. Base Emitter Reverse Voltage $I_B = f(V_{EB})$, V_{CE} = 2.5 V

5.5 Characteristic AC Diagrams

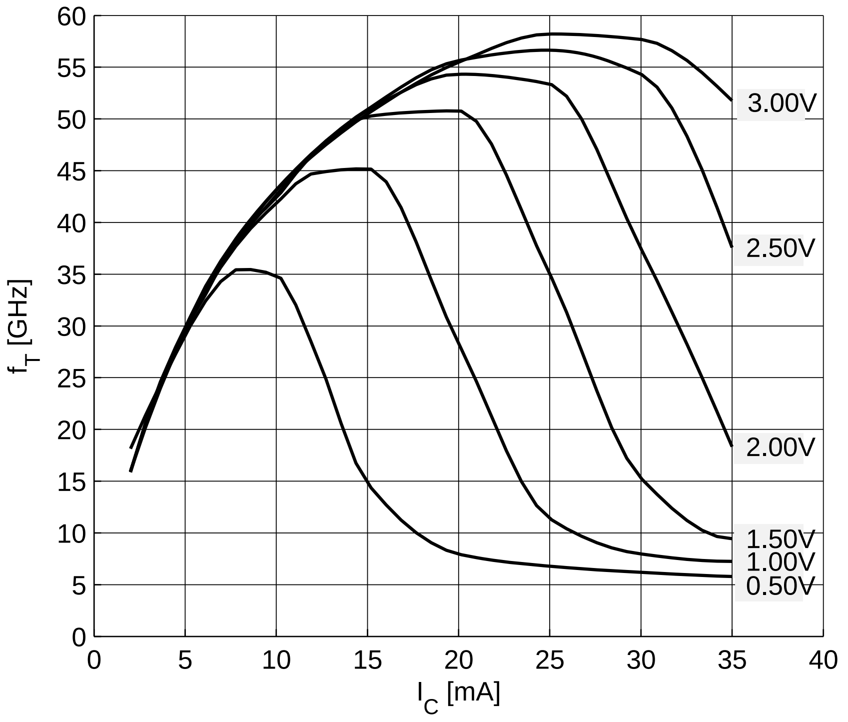


Figure 5-7 Transition Frequency $f_T = f(I_C)$, f = 1 GHz, V_{CE} = Parameter

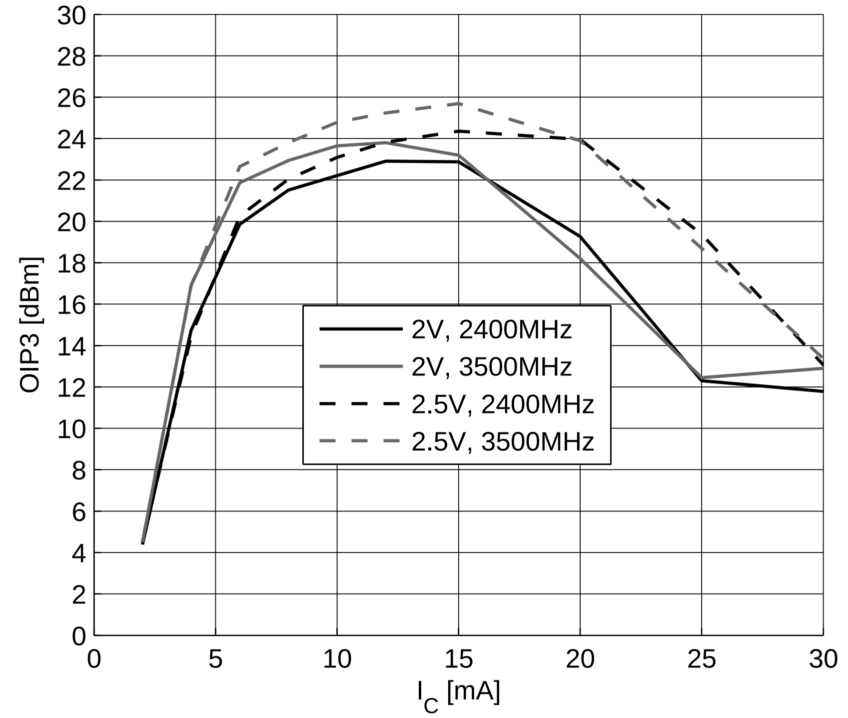


Figure 5-8 3rd Order Intercept Point at output $OIP3 = f(I_C)$, $Z_S = Z_L$ = 50 Ω, $V_{CE,}$ f = Parameters

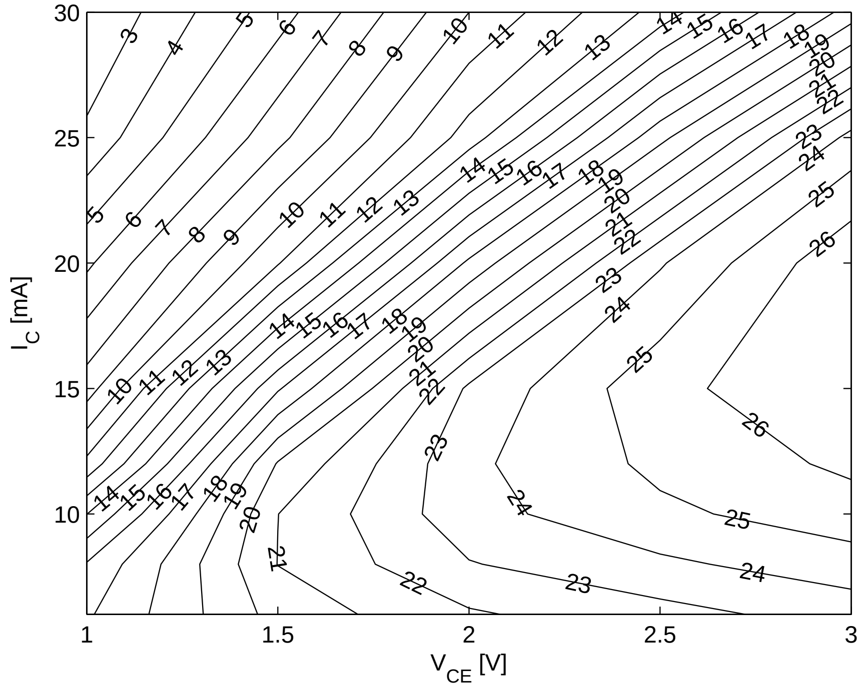


Figure 5-9 3rd Order Intercept Point at output $OIP3$ [dBm] = f (I_C, V_{CE}), Z_S = Z_L = 50 Ω, f = 3.5 GHz

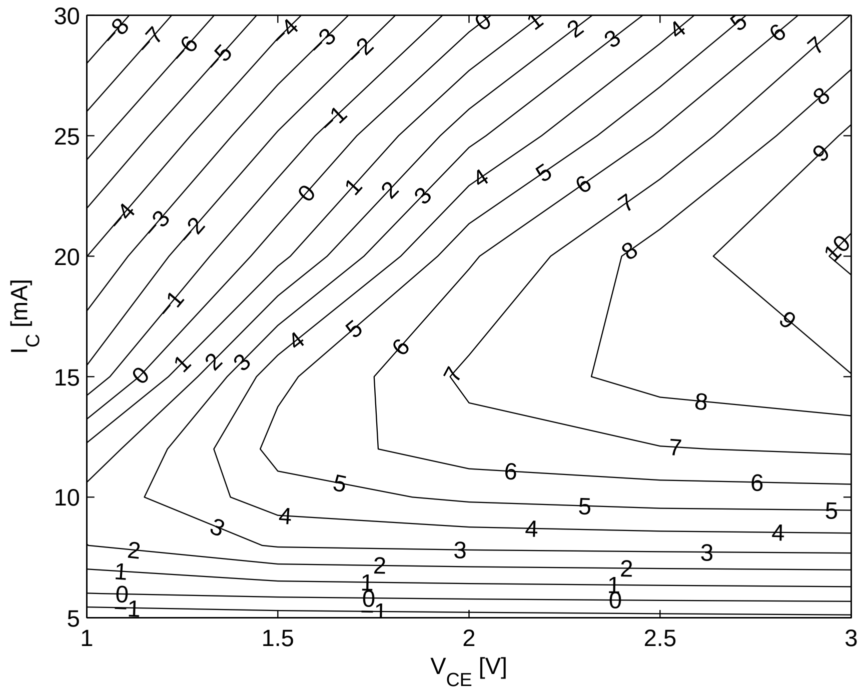


Figure 5-10 Compression Point at output OP_{1dB} [dBm] = f (I_C, V_{CE}), Z_S = Z_L = 50 Ω, f = 3.5 GHz

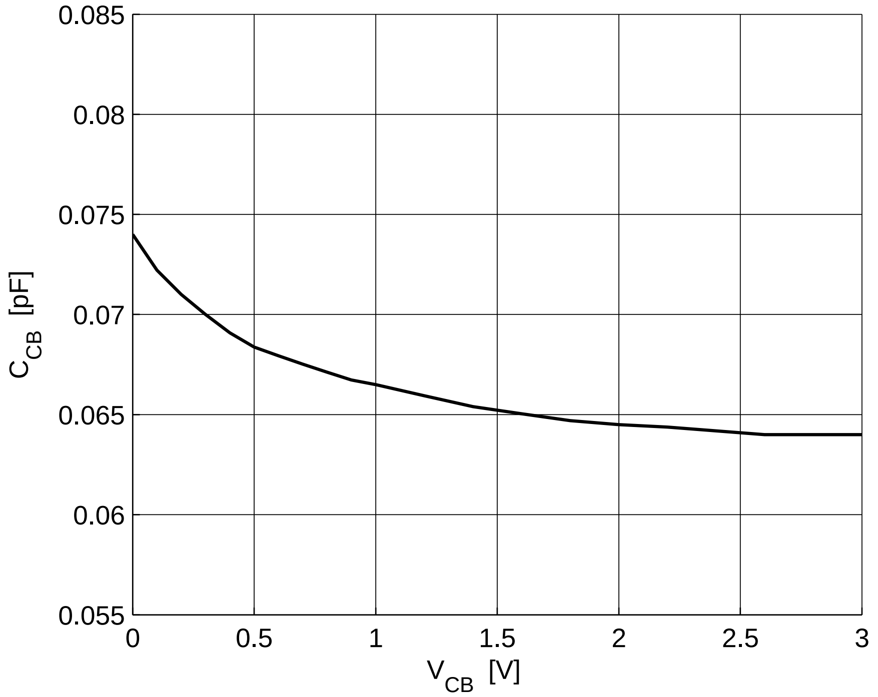


Figure 5-11 Collector Base Capacitance $C_{CB} = f(V_{CB})$, f = 1 MHz

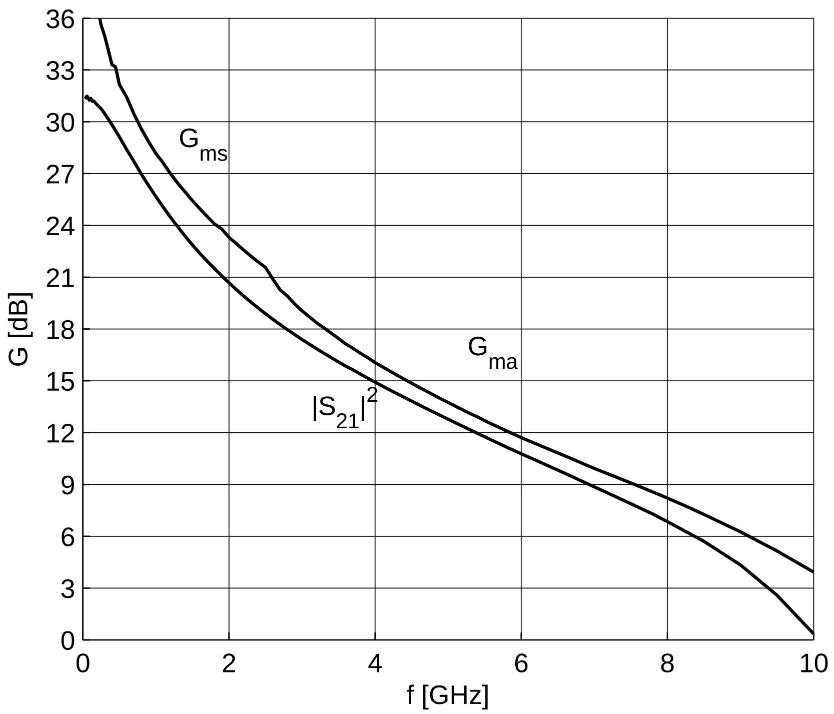


Figure 5-12 Gain G_{ma}, G_{ms}, $|S_{21}|^2 = f(f)$, V_{CE} = 2.5 V, I_C = 15 mA

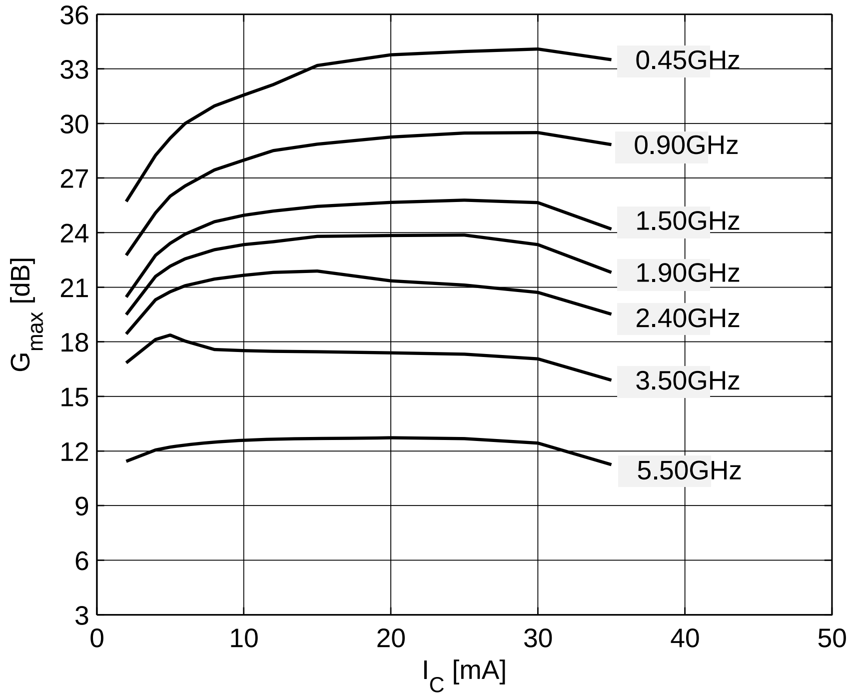


Figure 5-13 Maximum Power Gain $G_{max} = f(I_C)$, V_{CE} = 2.5 V, f = Parameter in GHz

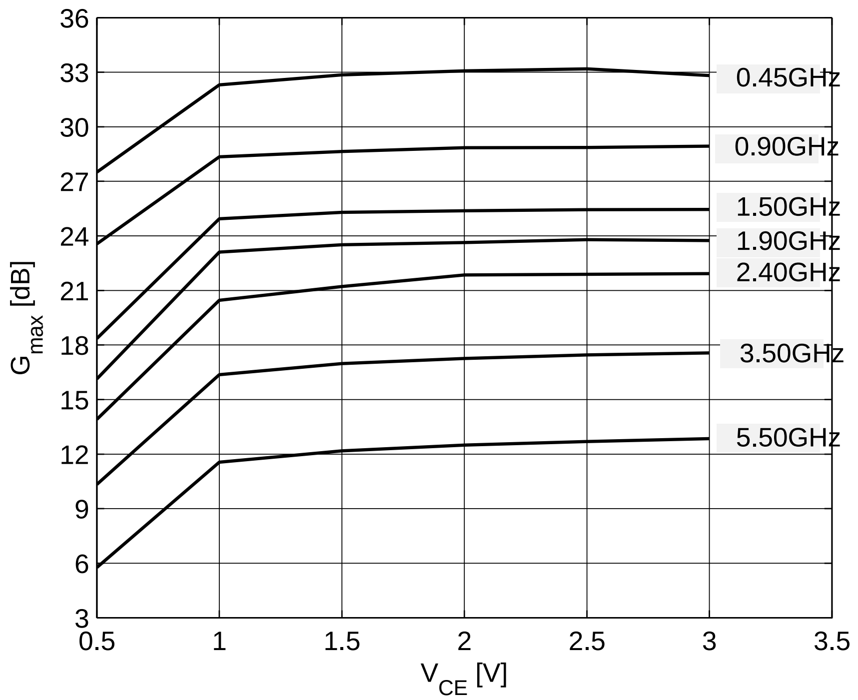


Figure 5-14 Maximum Power Gain $G_{max} = f(V_{CE})$, I_C = 15 mA, f = Parameter in GHz

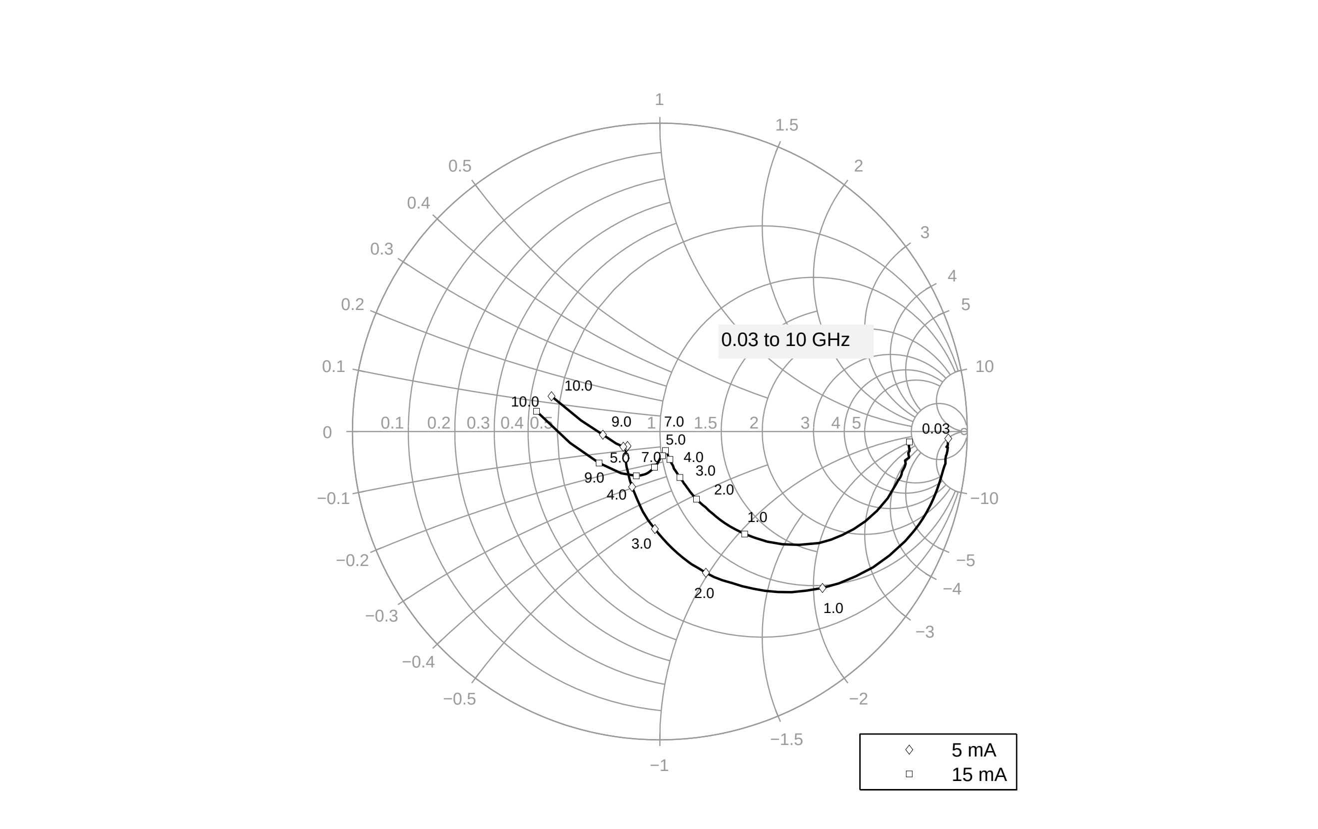


Figure 5-15 Input Reflection Coefficient $S_{11} = f(f)$, V_{CE} = 2.5 V, I_C = 5 / 15 mA

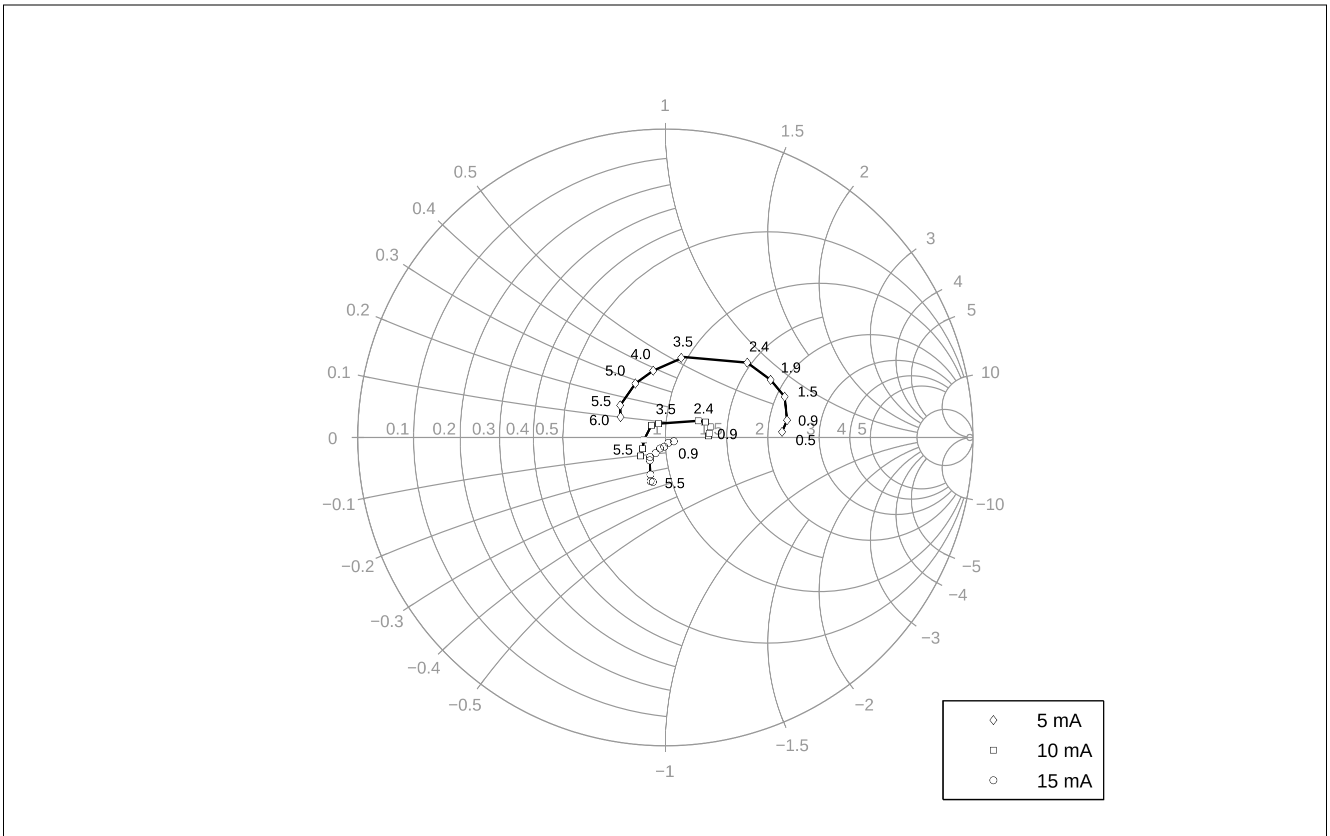


Figure 5-16 Source Impedance for Minimum Noise Figure $Z_{opt} = f(f)$, V_{CE} = 2.5 V, I_C = 5 / 10 / 15 mA

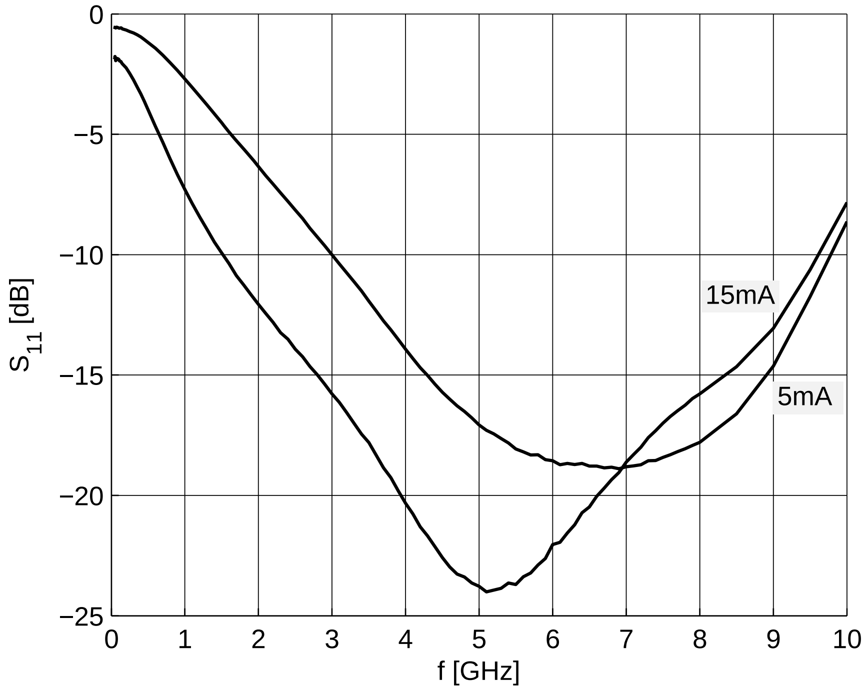


Figure 5-17 Input Reflection Coefficient S_{11} = f (f), V_{CE} = 2.5 V, I_C = 5 / 15 mA

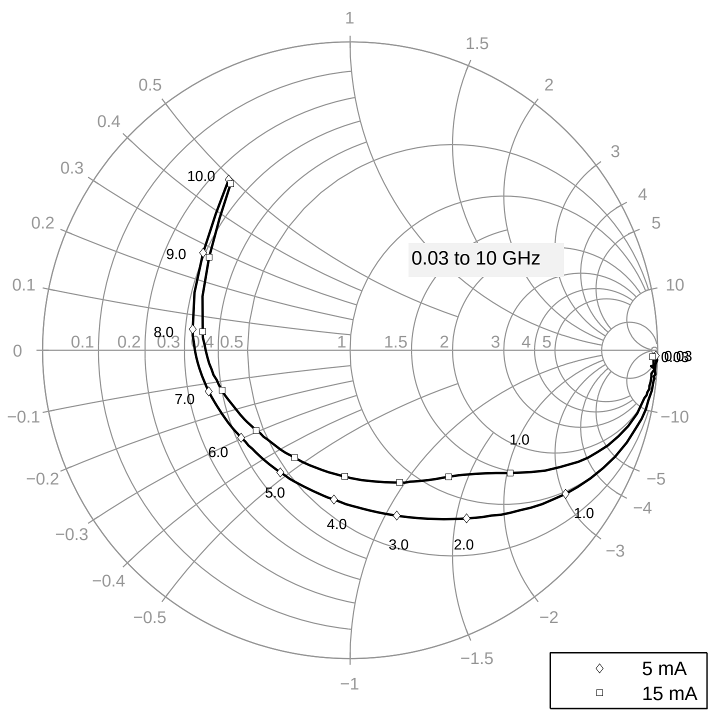


Figure 5-18 Output Reflection Coefficient S_{22} = f (f), V_{CE} = 2.5 V, I_C = 5 / 15 mA

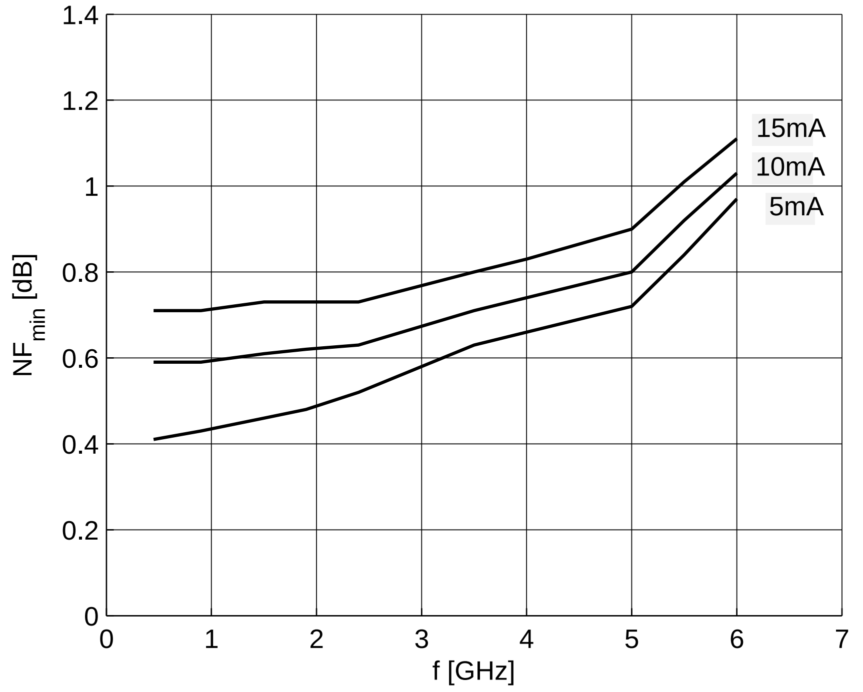


Figure 5-19 Noise Figure $NF_{min} = f\,(f)$, V_{CE} = 2.5 V, I_C = 5 / 10 / 15 mA, $Z_S = Z_{opt}$

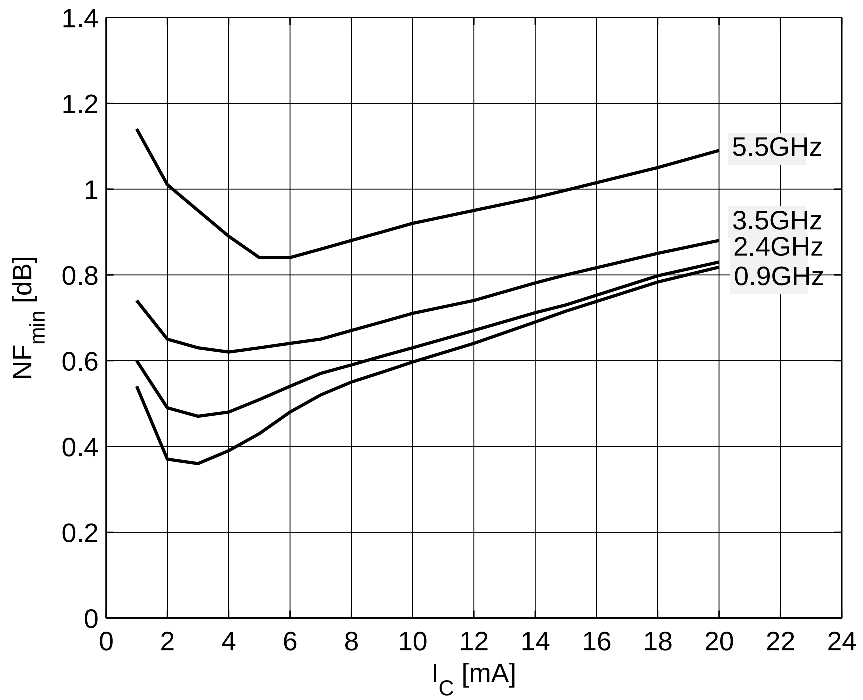


Figure 5-20 Noise Figure $NF_{min} = f\,(I_C)$, V_{CE} = 2.5 V, $Z_S = Z_{opt}$, f = Parameter in GHz

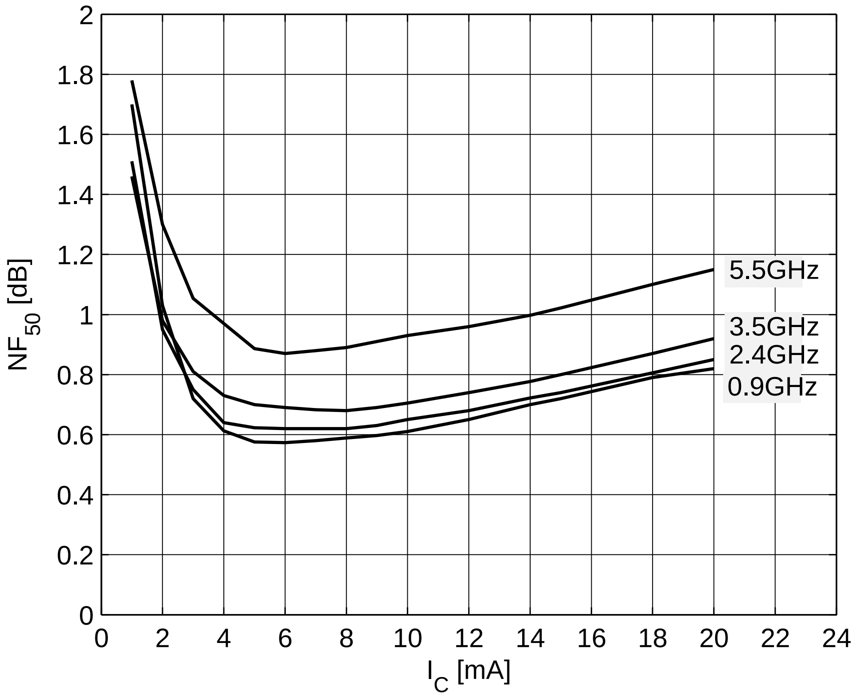


Figure 5-21 Noise Figure $NF_{50} = f(I_C)$, V_{CE} = 2.5 V, Z_S = 50 Ω, f = Parameter in GHz

Note: The curves shown in this chapter have been generated using typical devices but shall not be considered as a guarantee that all devices have identical characteristic curves. T_A = 25 °C

6 Simulation Data

For the SPICE Gummel Poon (GP) model as well as for the S-parameters (including noise parameters) please refer to our internet website. Please consult our website and download the latest versions before actually starting your design.
You find the BFP842ESD SPICE GP model in the internet in MWO- and ADS-format, which you can import into these circuit simulation tools very quickly and conveniently. The model already contains the package parasitics and is ready to use for DC and high frequency simulations. The terminals of the model circuit correspond to the pin configuration of the device.
The model parameters have been extracted and verified up to 12 GHz using typical devices. The BFP842ESD SPICE GP model reflects the typical DC- and RF-performance within the limitations which are given by the SPICE GP model itself. Besides the DC characteristics all S-parameters in magnitude and phase, as well as noise figure (including optimum source impedance, equivalent noise resistance and flicker noise) and intermodulation have been extracted.

7 Package Information SOT343

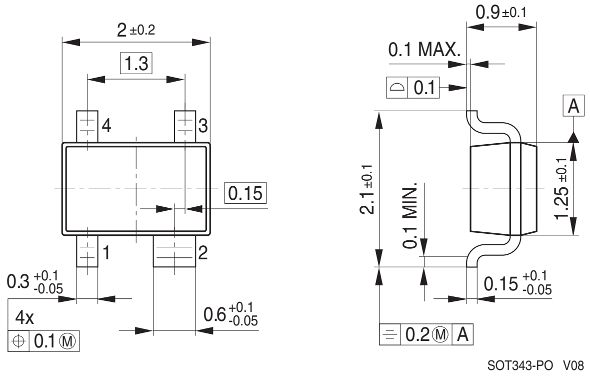


Figure 7-1 Package Outline

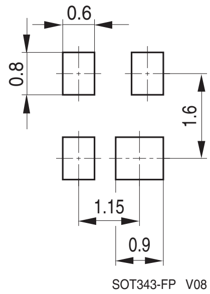


Figure 7-2 Package Footprint

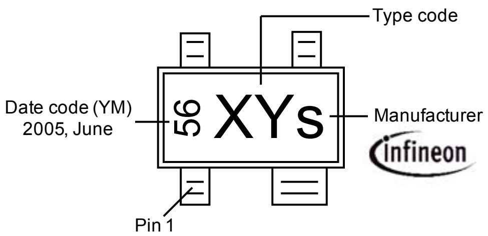


Figure 7-3 Marking Description (Marking BFP842ESD: T9s)

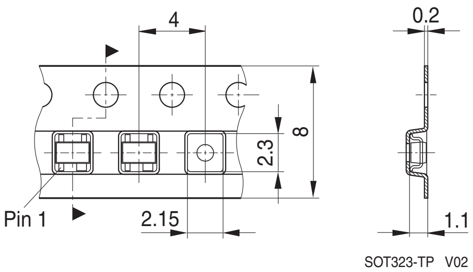


Figure 7-4 Tape dimensions

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Живое партнерство

ООО «ЛайфЭлектроникс» "LifeElectronics" LLC

ИНН 7805602321 КПП 780501001 Р/С 40702810122510004610 ФАКБ "АБСОЛЮТ БАНК" (ЗАО) в г.Санкт-Петербурге К/С 30101810900000000703 БИК 044030703

Компания «Life Electronics» занимается поставками электронных компонентов импортного и отечественного производства от производителей и со складов крупных дистрибьюторов Европы, Америки и Азии.

С конца 2013 года компания активно расширяет линейку поставок компонентов по направлению коаксиальный кабель, кварцевые генераторы и конденсаторы (керамические, пленочные, электролитические), за счёт заключения дистрибьюторских договоров

Мы предлагаем:

- *Конкурентоспособные цены и скидки постоянным клиентам.*
- *Специальные условия для постоянных клиентов.*
- *Подбор аналогов.*
- *Поставку компонентов в любых объемах, удовлетворяющих вашим потребностям.*

- *Приемлемые сроки поставки, возможна ускоренная поставка.*
- *Доставку товара в любую точку России и стран СНГ.*
- *Комплексную поставку.*
- *Работу по проектам и поставку образцов.*
- *Формирование склада под заказчика.*

- *Сертификаты соответствия на поставляемую продукцию (по желанию клиента).*
- *Тестирование поставляемой продукции.*
- *Поставку компонентов, требующих военную и космическую приемку.*
- *Входной контроль качества.*
- *Наличие сертификата ISO.*

В составе нашей компании организован Конструкторский отдел, призванный помогать разработчикам, и инженерам.

Конструкторский отдел помогает осуществить:

- *Регистрацию проекта у производителя компонентов.*
- *Техническую поддержку проекта.*
- *Защиту от снятия компонента с производства.*
- *Оценку стоимости проекта по компонентам.*
- *Изготовление тестовой платы монтаж и пусконаладочные работы.*

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